



GL250N03B0

GL Silicon N-Channel Power MOSFET

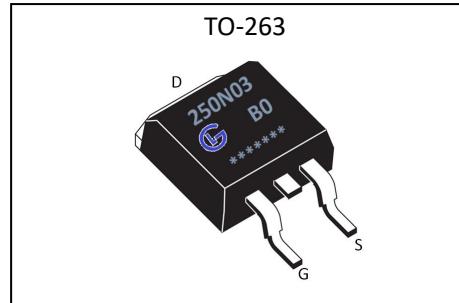
General Description

The GL250N03B0 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications. The package form is TO-263, which accords with the RoHS standard.

V_{DSS}	30	V
I_D	250	A
P_D	215	W
$R_{DS(ON)MAX}$	2.2	$m\Omega$

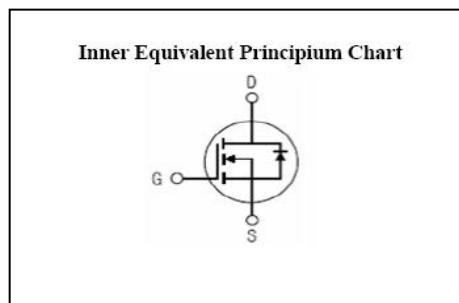
Features

- $R_{DS(ON)} < 2.2m\Omega @ V_{GS}=10V$
- High density cell design for ultra low $R_{ds(on)}$
- Fully characterized avalanche voltage and current
- Excellent package for good heat dissipation



Applications

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



Absolute ($T_c=25^\circ C$ unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	30	V
I_D	Continuous Drain Current	250	A
I_{DM}	Pulsed Drain Current	1000	A
V_{GS}	Gate-to-Source Voltage	± 20	V
P_D	Power Dissipation	215	W
E_{AS}	Single pulse avalanche energy ^{a5}	890	mJ
T_J, T_{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ C$

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device

Thermal Characteristics

Symbol	Parameter	Typ.	Units
$R_{\theta JC}$	Junction-to-Case ^{a2}	1.42	$^\circ C/W$



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Electrical Characteristics ($T_c=25^\circ C$ unless otherwise specified)

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	30	--	--	V
I_{DSS}	Drain to Source Leakage Current	$V_{DS}=30V, V_{GS}=0V, T_a=25^\circ C$	--	--	1.0	μA
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+20V$	--	--	0.1	μA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-20V$	--	--	-0.1	μA

ON Characteristics ^{a3}						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=85A$	--	1.6	2.2	$m\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	--	3.0	V

Pulse width $t_p \leq 380\mu s, \delta \leq 2\%$

Dynamic Characteristics ^{a4}						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g_{fs}	Forward Transconductance	$V_{DS}=5V, I_D=85A$	--	80	--	S
C_{iss}	Input Capacitance	$V_{GS}=0V, V_{DS}=15V$	--	6150	--	pF
C_{oss}	Output Capacitance	$f=1.0MHz$	--	1550	--	
C_{rss}	Reverse Transfer Capacitance		--	105	--	

Resistive Switching Characteristics ^{a4}						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD}=15V, I_D=85A$	--	13	--	ns
t_r	Rise Time		--	7.5	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	52	--	
t_f	Fall Time		--	8.6	--	
Q_g	Total Gate Charge	$V_{DD}=15V, I_D=85A$	--	98	--	nC
Q_{gs}	Gate to Source Charge		--	16	--	
Q_{gd}	Gate to Drain ("Miller")Charge		--	11	--	

Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _S	Continuous Source Current ^{a2} (Body Diode)		--	--	250	A
V _{SD}	Diode Forward Voltage ^{a3}	I _S =250A, V _{GS} =0V	--	--	1.2	V

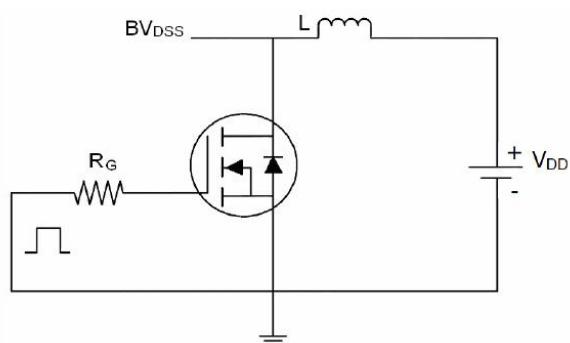
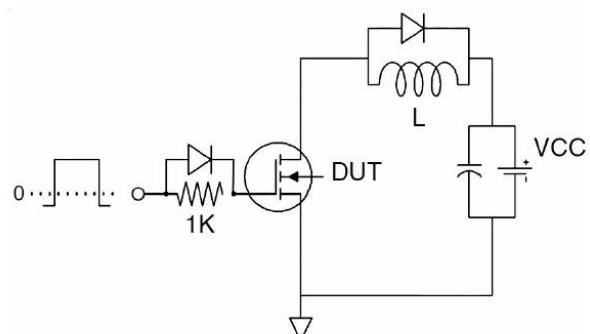
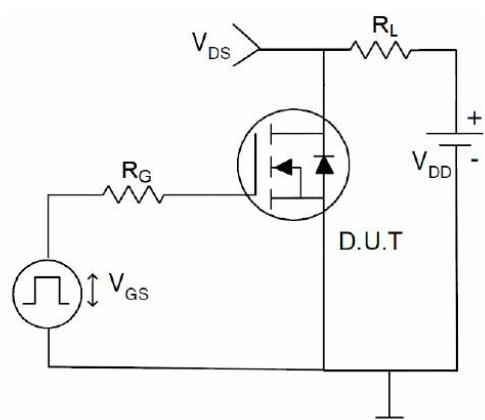
^{a1}: Repetitive Rating: Pulse width limited by maximum junction temperature.

^{a2}: Surface Mounted on FR4 Board, t≤10sec.

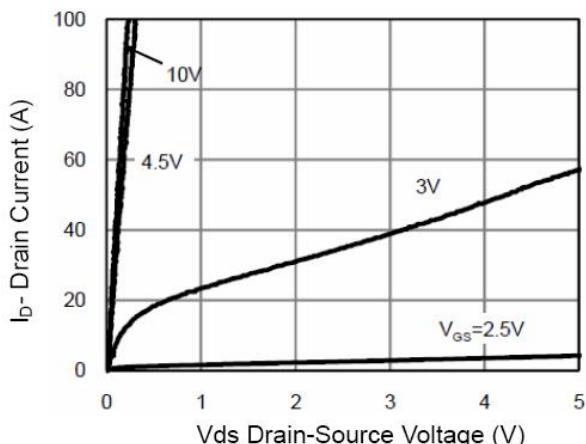
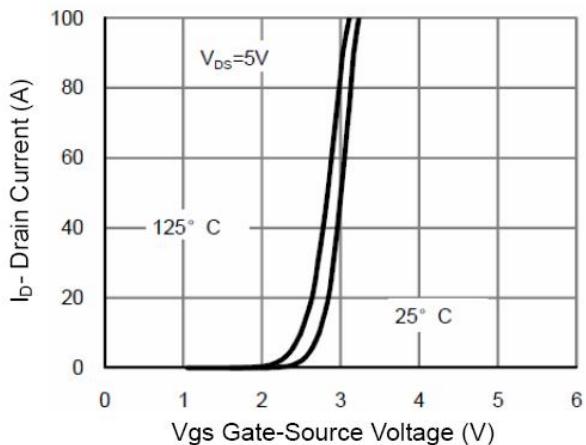
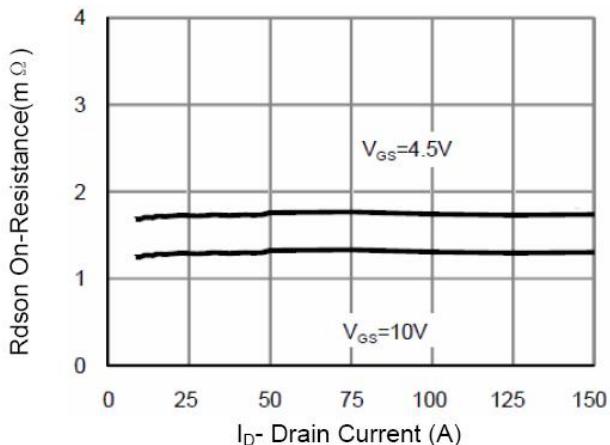
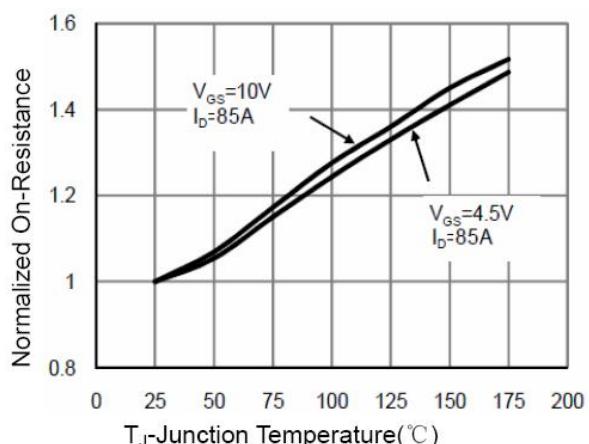
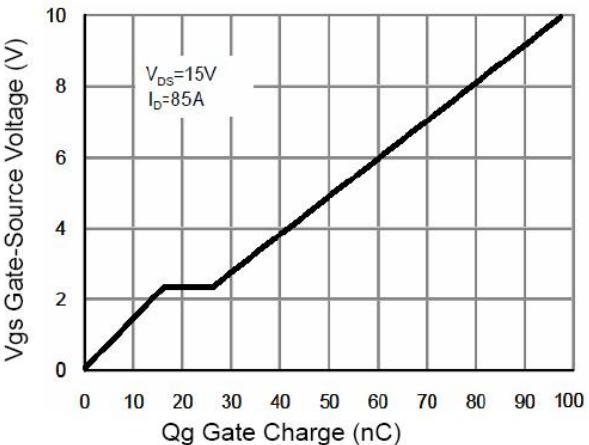
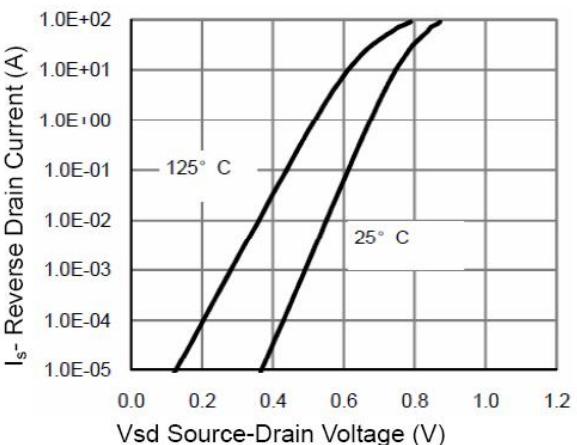
^{a3}: Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%.

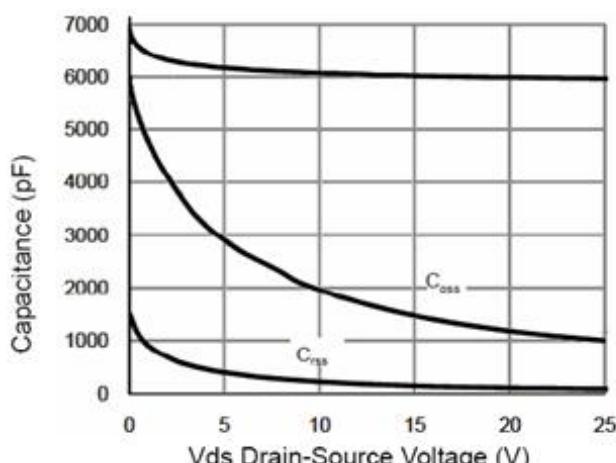
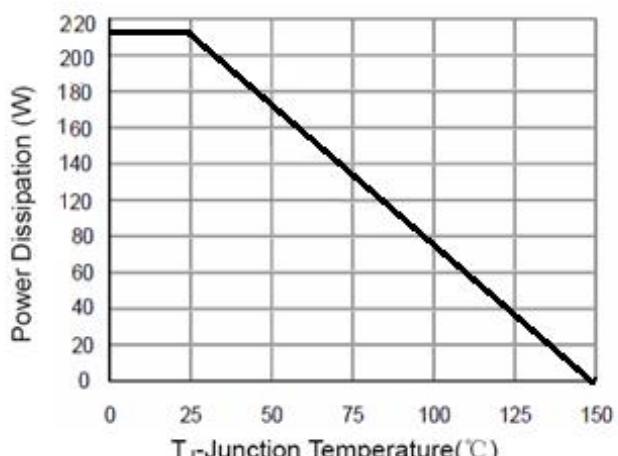
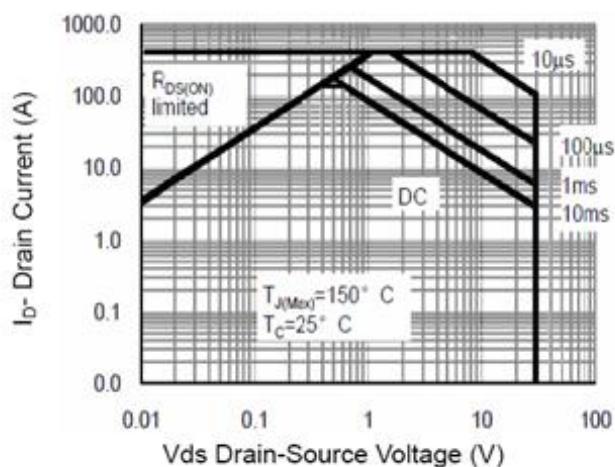
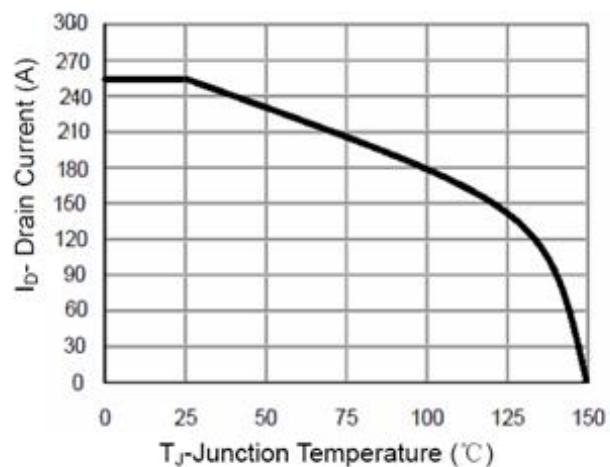
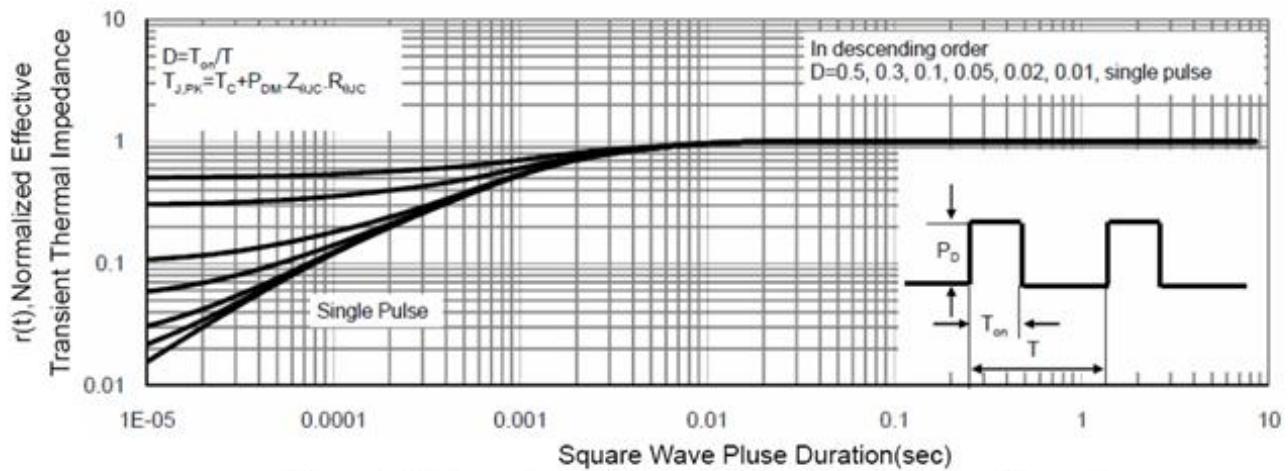
^{a4}: Guaranteed by design, not subject to production

^{a5}: EAS condition: T_j=25°C, V_{DD}=20V, V_G=10V, L=0.5mH, R_g=25Ω

Test Circuits
1) EAS test Circuit

2) Gate charge test Circuit

3) Switch Time Test Circuit


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Characteristics Curves

Figure 1 Output Characteristics

Figure 2 Transfer Characteristics

Figure 3 Rdson - Drain Current

Figure 4 Rdson-Junction Temperature

Figure 5 Gate Charge

Figure 6 Source- Drain Diode Forward

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Figure 7 Capacitance vs Vds

Figure 9 Power De-rating

Figure 8 Safe Operation Area

Figure 10 Current De-rating

Figure 11 Normalized Maximum Transient Thermal Impedance